


<b>Search Notes</b>  	<b>Application/Control No.</b>  10511525	<b>Applicant(s)/Patent Under Reexamination</b>  CHANG ET AL.
	<b>Examiner</b>  Rita J Desai	<b>Art Unit</b>  1625

SEARCHED			
Class	Subclass	Date	Examiner
546	18 and nAChR	4/16/08	RD
514	278 , 279, and nAChR	4/16/08	RD

SEARCH NOTES		
Search Notes	Date	Examiner
inventor search	4/16/08	Rd
Allowance conference with Ms. Janet Andres.	4/16/08	Rd

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
546	18 and nAChR	4/16/08	RD
514	279 and nAChR	4/16/08	RD